Notice of References Cited Application/Control No. 10/665,992 Examiner Sing P. Chan Applicant(s)/Patent Under Reexamination CHAUG ET AL. Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	Α	US-5,368,902	11-1994	Todd et al.	427/601
	В	US-6,426,143	07-2002	Voss et al.	428/378
	С	US-5,795,527	08-1998	Nakamura et al.	264/267
	D	US-4,078,935	03-1978	Nakagiri et al.	430/527
	Ε	US-2002/0083858	07-2002	MacDiarmid et al.	101/484
	F	US-4,714,631	12-1987	Aufderheide, Brian E.	427/250
	G	US-4,368,281	01-1983	Brummett et al.	523/458
	Н	US-6,140,025	10-2000	Imai et al.	430/325
	1	US-	,		
	J	US-			
	Κ	US-			
	L	US-			
	М	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N	GB 2207289 A	01-1989	United Kingdom	HINSLEY, CHRISTOPHE	H05K 03/02
	0					
	Р			·		
	Q					
	R					
	s					
	Т					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)						
	U							
	٧							
	w							
	х							

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)

Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.